MOSFET - N-Channel, SUPERFET[®] II, FRFET[®]

650 V, 76 A, 41 m Ω

FCH041N65EF

Description

SUPERFET II MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SUPERFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications. SUPERFET II FRFET MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.

Features

- 700 V @ $T_J = 150^{\circ}\text{C}$
- Typ. $R_{DS(on)} = 36 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q_g = 229 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 631 pF)
- 100% Avalanche Tested
- These Device is Pb-Free and is RoHS Compliant

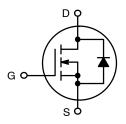
Applications

- LCD / LED / PDP TV
- Telecom / Server Power Supplies
- Solar Inverter
- AC-DC Power Supply



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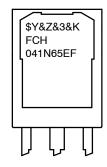


POWER MOSFET



TO-247 long leads CASE 340CH

MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code

= Lot Code

FCH041N65EF = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$, Unless otherwise noted)

| Symbol | Parameter | | Value | Unit |
|-----------------------------------|--|-------------------------------------|-------------|------|
| V _{DSS} | Drain to Source Voltage | | 650 | V |
| V _{GSS} | Gate to Source Voltage | DC | ±20 | V |
| | | AC (f > 1 Hz) | ±30 | |
| I _D | Drain Current | Continuous (T _C = 25°C) | 76 | Α |
| | | Continuous (T _C = 100°C) | 48.1 | |
| I _{DM} | Drain Current | Pulsed (Note 1) | 228 | Α |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | | 2025 | mJ |
| I _{AR} | Avalanche Current (Note 1) | | 15 | Α |
| E _{AR} | Repetitive Avalanche Energy (Note 1) | | 5.95 | mJ |
| dv/dt | MOSFET dv/dt Peak Diode Recovery dv/dt (Note 3) | | 100 | V/ns |
| | | | 50 | |
| P _D | Power Dissipation | (T _C = 25°C) | 595 | W |
| | | Derate Above 25°C | 4.76 | W/°C |
| T _J , T _{STG} | Operating and Storage Temperature Range | | -55 to +150 | °C |
| T _L | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds | | 300 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Repetitive rating: pulse width limited by maximum junction temperature.
2. $I_{AS} = 15 \text{ A}$, $R_G = 25 \Omega$, starting $T_J = 25^{\circ}\text{C}$.
3. $I_{SD} \le 38 \text{ A}$, $di/dt \le 200 \text{ A/µs}$, $V_{DD} \le 380 \text{ V}$, starting $T_J = 25^{\circ}\text{C}$.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Value | Unit |
|----------------|---|-------|------|
| $R_{	heta JC}$ | Thermal Resistance, Junction to Case, Max. | 0.21 | °C/W |
| $R_{	heta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 40 | |

PACKAGE MARKING AND ORDERING INFORMATION

| Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|------------------|-------------|---------|-------------------|-----------|------------|----------|
| FCH041N65EF-F155 | FCH041N65EF | TO-247 | Tube | N/A | N/A | 30 Units |

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|--------------------------------|--|---|------|------|-------|------|
| OFF CHARACT | ERISTICS | | | • | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $V_{GS} = 0 \text{ V, } I_D = 10 \text{ mA, } T_J = 25^{\circ}\text{C}$ | 650 | | | V |
| | | V _{GS} = 0 V, I _D = 10 mA, T _J = 150°C | 700 | | | V |
| $\Delta BV_{DSS}/\Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | I _D = 10 mA, Referenced to 25°C | | 0.72 | | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 650 V, V _{GS} = 0 V | | | 10 | μΑ |
| | | V _{DS} = 520 V, T _C = 125°C | | 145 | | Ì |
| I _{GSS} | Gate to Body Leakage Current | V _{GS} = ±20 V, V _{DS} = 0 V | | | ±100 | nA |
| ON CHARACTE | RISTICS | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | V _{GS} = V _{DS} , I _D = 7.6 mA | 3 | | 5 | V |
| R _{DS(on)} | Static Drain to Source On Resistance | V _{GS} = 10 V, I _D = 38 A | | 36 | 41 | mΩ |
| 9 _{FS} | Forward Transconductance | V _{DS} = 20 V, I _D = 38 A | | 71.7 | | S |
| DYNAMIC CHA | RACTERISTICS | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 9446 | 12560 | pF |
| C _{oss} | Output Capacitance | | | 366 | 490 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 35 | | pF |
| C _{oss} | Output Capacitance | V _{DS} = 380 V, V _{GS} = 0 V, f = 1MHz | | 197 | | pF |
| C _{oss(eff.)} | Effective Output Capacitance | V _{DS} = 0 V to 400 V, V _{GS} = 0 V | | 631 | | pF |
| Q _{g(tot)} | Total Gate Charge at 10 V | V _{DS} = 380 V, I _D = 38 A, V _{GS} = 10 V | | 229 | 298 | nC |
| Q _{gs} | Gate to Source Gate Charge | (Note 4) | | 50 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | | 90 | | nC |
| ESR | Equivalent Series Resistance | f = 1 MHz | | 0.6 | | Ω |
| SWITCHING CH | IARACTERISTICS | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 380 V, I _D = 38 A, V _{GS} = 10 V | | 55 | 120 | ns |
| t _r | Turn-On Rise Time | $R_g = 4.7 \Omega$ (Note 4) | | 65 | 140 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 175 | 360 | ns |
| t _f | Turn-Off Fall Time | | | 48 | 106 | ns |
| DRAIN-SOURC | E DIODE CHARACTERISTICS | | | | | |
| I _S | Maximum Continuous Drain to Source D | iode Forward Current | | | 76 | Α |
| I _{SM} | Maximum Pulsed Drain to Source Diode | Maximum Pulsed Drain to Source Diode Forward Current | | | 228 | Α |
| V _{SD} | Drain to Source Diode Forward Voltage | V _{GS} = 0 V, I _{SD} = 38A | | | 1.2 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _{SD} = 38 A, | | 207 | | ns |
| Q _{rr} | Reverse Recovery Charge | dI _F /dt = 100 A/μs | | 1.5 | | μC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

TYPICAL PERFORMANCE CHARACTERISTICS

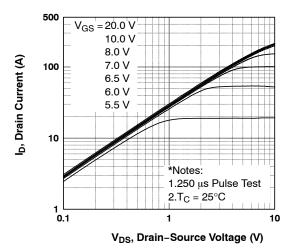


Figure 1. On-Region Characteristics

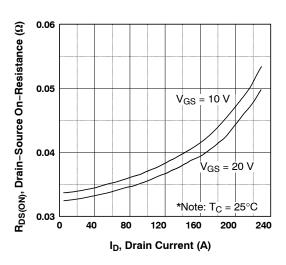


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

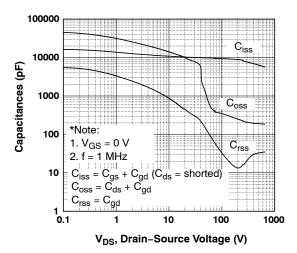


Figure 5. Capacitance Characteristics

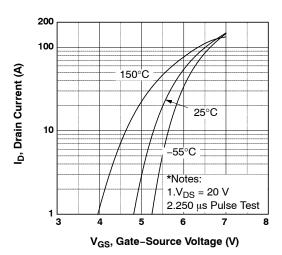


Figure 2. Transfer Characteristics

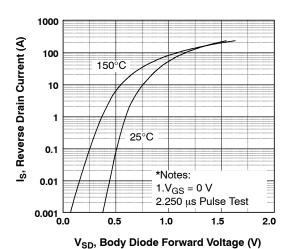


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

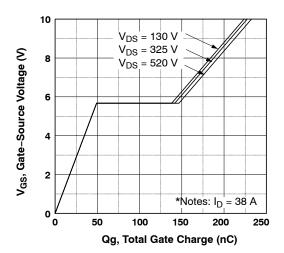


Figure 6. Gate Charge Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

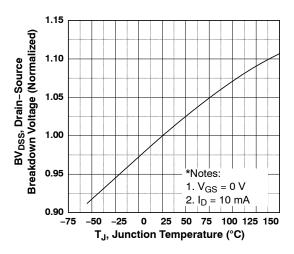


Figure 7. Breakdown Voltage Variation vs. Temperature

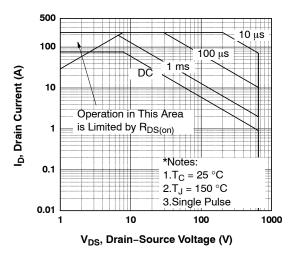


Figure 9. Maximum Safe Operating Area

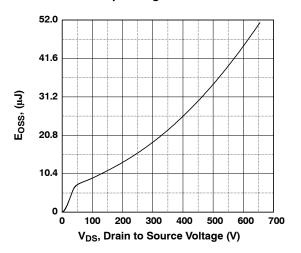


Figure 11. E_{OSS} vs. Drain to Source Voltage

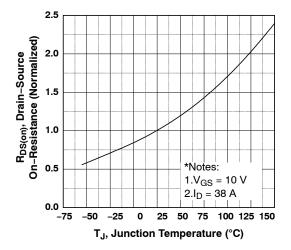


Figure 8. On-Resistance Variation vs. Temperature

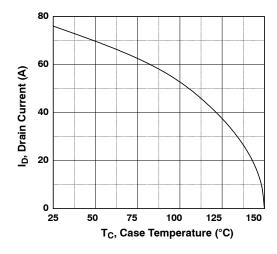


Figure 10. Maximum Drain Current vs. Case Temperature

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

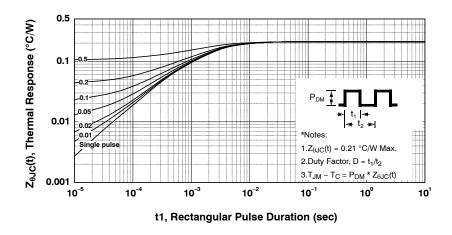


Figure 12. Transient Thermal Response Curve

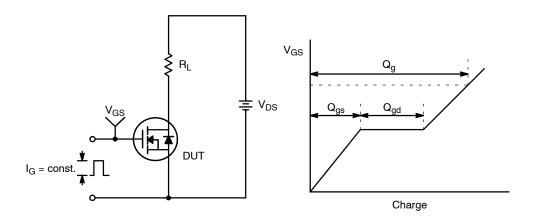


Figure 13. Gate Charge Test Circuit & Waveform

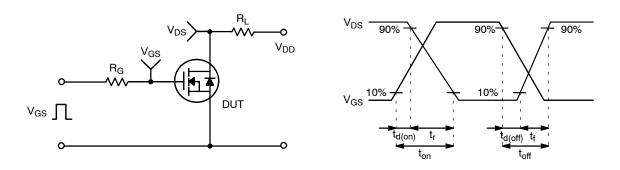


Figure 14. Resistive Switching Test Circuit & Waveforms

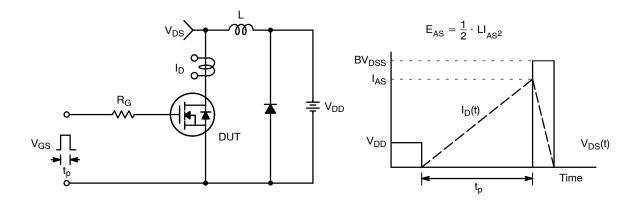


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

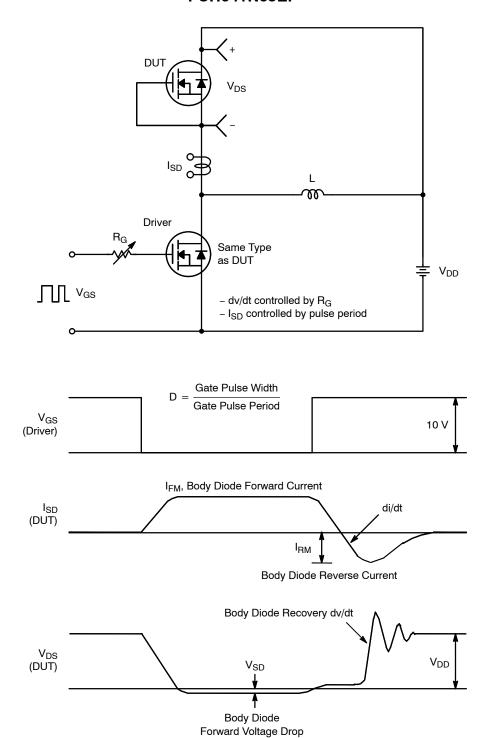
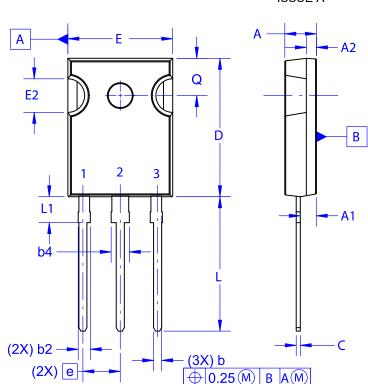


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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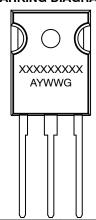
TO-247-3LD CASE 340CH **ISSUE A**





- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
 D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC **MARKING DIAGRAM***



XXXX = Specific Device Code

= Assembly Location

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

| | DATE | 09 OCT 2019 |
|--------|------|-------------|
| Ø P — | | P1 D2 |
| S E1 — | 2 | D1 |
| | | <u>.</u> |

| DIM | MILLIMETERS | | | | |
|------------|-------------|-------|-------|--|--|
| DIM | MIN | NOM | MAX | | |
| Α | 4.58 | 4.70 | 4.82 | | |
| A 1 | 2.29 | 2.475 | 2.66 | | |
| A2 | 1.40 | 1.50 | 1.60 | | |
| D | 20.32 | 20.57 | 20.82 | | |
| Е | 15.37 | 15.62 | 15.87 | | |
| E2 | 4.96 | 5.08 | 5.20 | | |
| е | ~ | 5.56 | ~ | | |
| L | 19.75 | 20.00 | 20.25 | | |
| L1 | 3.69 | 3.81 | 3.93 | | |
| ØΡ | 3.51 | 3.58 | 3.65 | | |
| Q | 5.34 | 5.46 | 5.58 | | |
| S | 5.34 | 5.46 | 5.58 | | |
| b | 1.17 | 1.26 | 1.35 | | |
| b2 | 1.53 | 1.65 | 1.77 | | |
| b4 | 2.42 | 2.54 | 2.66 | | |
| С | 0.51 | 0.61 | 0.71 | | |
| D1 | 13.08 | ~ | ~ | | |
| D2 | 0.51 | 0.93 | 1.35 | | |
| E1 | 12.81 | ~ | ~ | | |
| ØP1 | 6.61 | 6.73 | 6.85 | | |

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